

<b>Notice of References Cited</b>	Application/Control No. 10/784,348	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner Cam N. Nguyen	Art Unit 1793	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,650,051	07-1997	Wada et al.	204/157.52
*	B	US-3,470,019	09-1969	STEELE RAYMOND	502/326
*	C	US-3,591,649	07-1971	Kroll et al.	585/267
*	D	US-3,573,038	03-1971	Jung et al.	502/301
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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